Notice of References Cited Application/Control No. 10/594,069 Examiner SING P. CHAN Applicant(s)/Patent Under Reexamination TAKASAKI ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,660,562	12-2003	Lee, David	438/112
*	В	US-6,285,064	09-2001	Foster, Ronald R.	257/433
*	C	US-6,444,076	09-2002	Herndon et al.	156/249
*	D	US-6,200,402	03-2001	Amo, Mikuni	156/235
*	Е	US-4,752,180	06-1988	Yoshikawa, Kiyoshi	414/737
*	F	US-4,243,500	01-1981	Glennon, Alfred E.	522/33
*	G	US-4,671,846	06-1987	Shimbo et al.	438/455
*	Ι	US-7,089,986	08-2006	Hayasaka et al.	156/556
*	I	US-4,275,306	06-1981	Kato et al.	250/548
*	J	US-4,248,750	02-1981	Murakami et al.	524/588
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENT DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	Machine translation of JP 05-160340						
	\ \							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.